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Form PTO 1449 (Modified) LIST OF	REFE	U.S. DEPARTMENT PATENT AND TRAI RENCES CITED BY AP	DEMARK OFFICE	ATTY DOCKET NO. 213301US0PCT APPLICANT Heiko MAAS, et al.	JAN 1 2 2		SERIAL 09/926,	-	
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A	AS	Ullmann's Encyclopedia of Industrial Chemistry, 5 th Ed., Vol. A21, page 502.							
	AT	Ullmann's Encyclopedia of Industrial Chemistry, 5 th Ed., Vol. A18, page 231.							
	AU	Ullmann's Encyclopedia of Instudtrial Chemistry, 6 th Ed., Vol. 17, page 22.							
	AV	Ullmann's Encyclopedia of Industrial Chemistry, 5 th Ed., Vol. A5, pages 326-327.							
	AW	Ullmann's Encycloped	ia of Industrial	Chemistry, 6 th Ed., Vol. 1	6, pages 327-3	328, Chapte	r 2.2		
	AX	Ulimann's Encycloped	ia of Industrial	Chemistry, 6 th Ed., Vol. 1	6, pages 322-3	328.			
Â	AY	Ullmann's Encycloped	ia of Industrial	Chemistry, 5 th Ed., Vol. A	18, page 227				
	AZ	\sim					Additional References sheet(s) attached		
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